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RESISTORS, FIXED, WIREWOUND, BASED ON TYPE RWR 80 ESCC Detail Specification No. 4002/003

ISSUE 1 October 2002





ESCC Detail Specification

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RESISTORS, FIXED, WIREWOUND, BASED ON TYPE RWR 80

ESA/SCC Detail Specification No. 4002/003



space components coordination group

		Approved by			
Issue/Rev. Date		SCCG Chairman	ESA Director General or his Deputy		
Issue 3	April 1991	- Rowalh	1.1 late		
Revision 'A'	March 1994	Tonomical	t. leden		
Revision 'B'	November 1996	Sa mill	Hours		
Revision 'C'	April 1999	Sa mitt	A som.		



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DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date		CHANGE Item	Approved DCR No.	
		This Issue supersedes	Issue 2 and incorporates all modifications defined		
			to Issue 2 and the following DCR's:-		
1		Cover page			
		DCN			
			Title and contents amended	22845	
		Para. 2 :	Reference to MIL-STD-1276 deleted	22845/	
				23454	
			Type Variant identification table added	22845	
			"(2)" deleted from Column Headings	23454 22845	
1			"05" and "06" added to Column Headings ppm/°C corrected to "10-6/°C"	23454	
			Note reference added to Temperature	22845/	
		•	Characteristics	23454	
			Resistance Values corrected	22845/	
				23454	
		:	Weights amended	23454	
1		!	Existing Note 2 deleted and new Note 2 added	22845/	
				23454	
			No. 6 Unit changed from "sec" to "s"	22845	
		•	New No. 8 added	22845	
		"	: Title amended : Undertitle added	23454 23454	
		I .	: Amended to incorporate coated components and	23434	
	. (P) - (P)		new Variables		
			Symbol "I _T " added	23454 21019	
			: New second paragraph added : Amended to add "Maximum Time Constant"	22845	
1		1	: Amended to add "Maximum Time Constant"	22845	
			: Title amended	21025	
			: MIL-STD-1276 deleted. ESA/SCC 23500 added	21025/	
1				22845	
			: "Electrical" added to (b)	23454	
			: After Type Variant "(see Table 1(a))" added	23454	
			: After Testing, Level, "(B or C, as applicable)" added	23454	
			: After Tolerance, "(±0.1%)" added	23454	
			: "Temperature Coefficient" changed to "Temperature Characteristic of Resistance and	22845	
1			: "(±50.10-6/°C)" added	23454	
			: In Title and Text, Numerical changed to "Resistance"		
		Para. 4.5.3.3	: "Temperature Coefficient" and "±ppm/°C" changed to "Temperature Characteristic of Resistance" and "±10-6/°C"		
		Para. 4.6.2	: AQL changed to "0.65% (Level II)"	22845	
1		Para. 4.7.1	: In 3rd sentence, "(Δ)" added after values	23454	
1			: In 3rd sentence text amended	23454	
			: Text amended	23454	
			: No. 3(a) renumbered "3"	22845	
		1	: No. 3(b) deleted	22845	
1		Table 3	: "Specification" column heading amended	23454 22845	
<u>L</u>		<u> </u>	: In No. 2, Limits amended	22040	



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Rev. Letter	Rev. Date	CHANGE Item			
		Table 4 : No. Column added : "Specification" and "Test Conditions" columns retitled and entries reworded : "±" added to Limit : In Notes, "±" added to value and value amended Table 5 : No. 3, amended Figure 5 : Title "Figure 5(a), Parallel Circuit" added to existing Circuit and Circuit amended : Second test Circuit, "Figure 5(b) - Series Circuit" added : Note amended Para. 4.8 : Title amended Paras. 4.8.1, 4.8.2, 4.8.3 : Title and first sentence amended Para. 4.8.2 : Second sentence added Table 6 : Title amended : Table restructured and amended	23454 23454 22845/ 23454 22845/ 23454 22845/ 23454 22845/ 23454 2323 23454 2323 23454 2323 23454 2323 23454 2323 23454 2323 23454 2323 23454		
'A'	March '94	P1. Cover Page P2A. DCN P10. Para. 4.4.2 : Material type amended	None None 221091		
'B'	Nov. '96	P1. Cover Page P2A. DCN P17. Table 6 : Table updated P18. Table 6 : Table updated	None None 23763 23763		
'C'	Apr. '99	P1. Cover Page P2A. DCN P7. Table 1(b) : Nos. 5(a), 5(b) and 6 deleted in toto and Nos. 7 and 8 renumbered as "5" and "6" respectively P9. Para. 4.2.2 : New Deviation "(a)" added P14. Table 2 : Specification and Test Conditions columns amended P17. Table 6 : No. 4, Test Method and Conditions amended	None None 221509 221509 221509 221509		



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None.

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1. **GENERAL**

1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for Resistors, Fixed, Wirewound, based on Type RWR 80. It shall be read in conjunction with ESA/SCC Generic Specification No. 4002, the requirements of which are supplemented herein.

1.2 TYPE VARIANTS AND RANGE OF COMPONENTS

Variants of the basic type resistors and the range of components covered by this specification are given in Table 1(a)

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the resistors specified herein, are as scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The derating information applicable to the resistors specified herein is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the resistors specified herein are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram for the resistors specified herein is shown in Figure 3.

2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

(a) ESA/SCC Generic Specification No. 4002, Resistors, Fixed, Wirewound.



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TABLE 1(a) - TYPE VARIANTS AND RANGE OF COMPONENTS

VARIA	NIT	COATED	MOULDED	INDUCTIVE	NON-INDUCTIVE	LEA	\DS
VADIA	AINT	COATED	MOOLDED	INDOCTIVE	NON-INDOCTIVE	25mm	35mm
01		Х	-	Х	-		Х
02	2	X	-	-	X	-	Х
03	3	X	-	Х	-	Х	-
04	1	X	-	-	X	Х	-
05	5	-	X	X	-	Х	-
06	3	-	X	-	X	Х	-

Tolerance	Variants 01, 03 an Inductively Wou		Variants 02, 04 and 06 Non-inductively Wound		
(%)	Resistance Range (1) (g) (g) (g) (g) (g) (g)		Resistance Range (1) Rn (Ω)	Weight (g) max.	
± 0.1	0.5 to 2200	0.7	10 to 1580	0.7	
± 0.5	0.5 to 2200		10 to 1580		
± 1.0	0.25 to 2200		10 to 1580		
± 2.0	0.125 to 2200		10 to 1580		
± 5.0	0.1 to 2200		10 to 1580	1	
Temp. Characteristic of Resistance 10 ⁻⁶ /°C (Note 2)	Resistance Value (Ω)				
±30	Rn ≥10				
± 50	1.0 < Rn < 10				
± 100		Rn :	≤1.0		

NOTES

- 1. The critical value is outside the resistor range.
- 2. For information only for values less than 5 ohms.



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TABLE 1(b) - MAXIMUM RATINGS

NO.	CHARACTERISTIC	SYMBOL	MAXIMUM RATING	UNIT	REMARKS
1	Rated Dissipation	P _n	2.0	W	Up to +25°C 1.6W at +70°C
2	Limiting Element Voltage	U_L	120	V	·
3	Rated Voltage	U _R	√PnRn or (1) U _L	V	Rn is the rated resistance
4	Operating Temperature Range	T _{op}	55 to + 275	°C	T _{amb}
5	Soldering Temperature	T _{sol}	+ 245	°C	Soldering Time ≤10s Distance from body ≥1.5mm
6	Maximum Time Constant (For Non-inductive Resistors)	L/R	20 7.4	ns ns	For values <50Ω For values ≥50Ω

NOTES

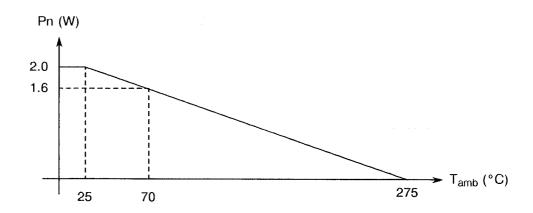
1. Whichever is smaller.



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FIGURE 1 - PARAMETER DERATING INFORMATION



Rated Power versus Temperature

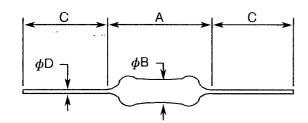
FIGURE 2 - PHYSICAL DIMENSIONS

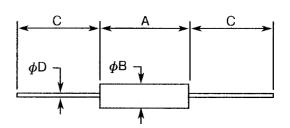
FIGURE 2(a) - COATED COMPONENT

VARIANTS 01, 02, 03 AND 04

FIGURE 2(b) - MOULDED COMPONENT

VARIANTS 05 AND 06





SYMBOL	MILLIMETRES		NOTES
STIVIBOL	MIN.	MAX.	NOTES
Α	9.52	11.1	
В	1.6 1.6	3.8 4.0	Variants 01, 02, 03 and 04 Variants 05 and 06
С	35 25	- -	Variants 01 and 02 Variants 03, 04, 05 and 06
D	0.5	0.7	

FIGURE 3 - FUNCTIONAL DIAGRAM

______R



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3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used:-

 I_T = Test current.

R_A = Resistance value measured at ambient temperature (+22±3 °C).

R_i = Insulation resistance.

 U_T = Test voltage.

 U_{proof} = d.c. or r.m.s. voltage proof.

 $U_{over L}$ = Overload voltage.

4. REQUIREMENTS

4.1 GENERAL

The complete requirements for procurement of the resistors specified herein shall be as stated in this specification and ESA/SCC Generic Specification No. 4002 for Resistors, Fixed, Wirewound. Deviations from the Generic Specification, applicable to this specification only, are detailed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirement and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

4.2.1 Deviations from Special In-process Controls

None.

4.2.2 <u>Deviations from Final Production Tests (Chart II)</u>

(a) Para. 9.1, Overload: The conditions shall be as follows:-

Voltage: √5PnRn or 2UL, whichever is less.

Duration: 5 seconds.

If better than 0.1%, use the Figure 1 curve.

4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)

None.

4.2.4 Deviations from Qualification Tests (Chart IV)

(a) Para. 9.18, Maximum Time Constant: Not applicable to inductive resistors.

4.2.5 Deviations from Lot Acceptance Tests (Chart V)

(a) Para. 9.18, Maximum Time Constant: Not applicable to inductive resistors.

4.3 MECHANICAL REQUIREMENTS

4.3.1 Dimension Check

The dimensions of the resistors specified herein shall be checked. They shall conform to those shown in Figure 2.

4.3.2 Weight

The maximum weight of the resistors specified herein shall be as per Table 1(a).



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4.3.3 Robustness of Terminations

The requirements for robustness of termination testing are specified in Section 9 of ESA/SCC Generic Specification No. 4002. The test conditions shall be as follows:-

Applied Force: 10 Newtons.

Duration

: 5 to 10 seconds.

4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the resistors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

4.4.1 **Enclosure or Protective Coating**

Resistor assemblies shall be protected by a coating or enclosure of moisture-resistant insulating material which shall completely cover the outside of the resistor element, including connections of terminations. The coating shall not crack, craze, drip, run or form globules at any temperature up to and including +275°C, regardless of the mounting position of the resistor.

The protective coating or enclosure shall be such that it minimises the establishment of leakage paths between the terminals resulting from collection of moisture film on the outside surface of the resistor.

4.4.2 Lead Material and Finish

The material shall be Type 'L' with Type '3' finish in accordance with the requirements of ESA/SCC Basic Specification No. 23500.

4.4.3 Wire

Each resistor shall be wound with a conductor having no joints, welds or bands within each terminated resistance element. In no case shall the nominal diameter be less than 20 microns.

4.5 MARKING

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with ESA/SCC Basic Specification No. 21700 and the following paragraphs. Each component shall be marked in respect of:-

- (a) The SCC Component Number.
- (b) Electrical Characteristics and Ratings.
- (c) Traceability Information.

4.5.2 The SCC Component Number

The SCC Component Number shall be constituted and marked as follows:

			400	200301B	ì
Detail Specification Number]	
Type Variant (see Table 1(a)) -		 	 		
Testing Level (B or C, as applica	ıble)	 	 		



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4.5.3 <u>Electrical Characteristics and Ratings</u>

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Numerical value.
- (b) Tolerance.
- (c) Temperature Characteristic of Resistance.

The information shall be constituted and marked as follows:-

	25H2 B 3
Value (25.5 ohms)	
Tolerance (±0.1%)	
Temperature Characteristic of Resistance (±50.10-6/°C)	

4.5.3.1 Resistance Values

Resistance values shall be expressed by means of the following codes.

The unit quantity for marking shall be Ohms.

RESISTANCE VALUE	CODE
0.XXX	RXXX
X.XX	XRXX
XX.X	XXRX
XXX	XXX0
XXX 10 ¹	XXX1

For values of 100 and above, the first three digits (X) represent significant figures and the last digit specifies the number of zeros to follow.

When values of less than 100 are required, the letter 'R' is used to indicate the decimal point. When the letter is used, all succeeding digits represent significant figures.

4.5.3.2 Tolerance

The tolerances on numerical values shall be indicated by the letter codes specified hereafter:-

TOLERANCE (%)	CODE LETTER
± 0.1	В
± 0.5	D
± 1.0	F
± 2.0	G
± 5.0	J



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4.5.3.3 Temperature Characteristic of Resistance

The temperature characteristic of resistance shall be indicated by the numerical codes specified hereafter:-

DIGIT	TEMPERATURE CHARACTERISTIC OF RESISTANCE ± 10-6 / °C
9	30
3	50
4	100

4.5.4 Traceability Information

Traceability information shall be marked in accordance with ESA/SCC Basic Specification No. 21700.

4.5.5 Marking of Small Components

Where it is considered that a component is too small to accommodate the marking as specified above, as much as space permits shall be marked. The order of precedence shall be as specified in Para. 4.5.1.

The marking information in full shall accompany each component in its primary package.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured at room temperature are scheduled in Table 2. The measurements shall be performed at T_{amb} = +22 ±3 °C.

4.6.2 <u>Electrical Measurements at High and Low Temperatures</u>

The parameters to be measured on a sample basis at high and low temperatures are scheduled in Table 3. AQL shall be 0.65% (Level II) out of the total production lot. The distribution of the sample shall be as follows:-

- 1/3 with lowest resistance values.
- 1/3 with highest resistance values.
- 1/3 with median resistance values.

4.6.3 Circuits for Electrical Measurements (Figure 4)

Not applicable.

4.7 BURN-IN TESTS

4.7.1 Parameter Drift Values

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Measurements shall be performed at $T_{amb} = +22 \pm 3$ °C. The parameter drift values (Δ) applicable to the parameter scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.



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4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 4002. The conditions for burn-in shall be as specified in Table 5. Resistors shall be tested with a d.c. voltage with a ripple not exceeding 5%. A voltage of 120V or $\sqrt{P_n}R_n$ (see Figure 5(a)) or a current of 120V ÷ Rn or $\sqrt{P_n}$ ÷ Rn (see Figure 5(b)), shall be applied in cycles of 90 minutes "on" and 30 minutes "off" throughout the test. The resistors shall be connected by their terminations to suitable clips on a rack of insulating material.

The resistors shall be so arranged that the temperature of any one resistor does not appreciably influence the temperature of any other resistor. There shall be no undue draught over the resistors. After the period specified in the Generic Specification, the resistors shall be removed from the chamber and allowed to cool under normal atmospheric conditions for a minimum of 4 hours.

4.7.3 Electrical Circuits for Burn-in

Alternative circuits for use in performing the burn-in tests are shown in Figures 5(a) and 5(b) of this specification.



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TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE

NO	CHADACTEDISTIC	PACTERISTIC SYMBOL	ESA/SCC 4002 TEST	TEST	TOLERANCE	LIM	UNIT	
NO.	NO. CHARACTERISTIC SYMBO		METHOD	CONDITIONS	(%)	MIN	MAX	ONIT
1	Resistance	R _A	Para. 9.5.1.1	Para. 9.5.1.1	0.1	0.999 R _n	1.001 R _n	Ω
					0.5	0.995 R _n	1.005 R _n	
					1.0	0.99 R _n	1.01 R _n	
					2.0	0.98 R _n	1.02 R _n	
					5.0	0.95 R _n	1.05 R _n	
2	Insulation Resistance	R _i	Para. 9.5.1.2	Para. 9.5.1.2.1	All	1 000	-	ΜΩ
3	Voltage Proof	U _{proof}	Para. 9.5.1.3	Para. 9.5.1.3.1	All	500	••	Vrms

NOTES

1. Measurements on a sample basis; sample size as specified in Para. 4.6.2.

TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

NO.	O L CHARACTERISTIC ISYMBOLL AND TEST L	SVMBOL		TEST	RESIST.	LIMITS		UNIT
NO.		OTANAO I ENISTIO	CONDITION	RANGE	MIN	MAX	ONLI	
1(a)	1(a) Resistance Change between -55(+3-0) °C and +22±3 °C Resistance Change R ESA/SCC Generic Spec. No. 4002	between -55(+3-0) °C R Spec. No. 4002	Para. 9.5	R _n ≤1.0	-0.8	+0.8	%	
			Spec. No. 4002		1.0 <r<sub>n<10</r<sub>	-0.4	+0.4	
					R _n ≥10	-0.25	+0.25	
1(b)	Resistance Change <u>AR</u> ESA/SCC Generic between +175±3 °C R Spec. No. 4002		Para. 9.5	R _n ≤1.0	-1.5	+1.5	%	
	between +175±3 °C and +22±3 °C			1.0 < R _n < 10	-0.75	+0.75		
			R _n ≥10	-0.45	+0.45			



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TABLE 4 - PARAMETER DRIFT VALUES

NO.	CHARACTERISTIC	SYMBOL	SPEC. AND/OR TEST METHOD	TEST CONDITION	CHANGE LIMITS (Δ)	UNIT
1	Resistance Change	<u>Δ R</u> R	As per Table 2	As per Table 2	±0.2 (1)	%

NOTES

1. or $\Delta R = \pm 0.05\Omega$, whichever is greater.

FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable

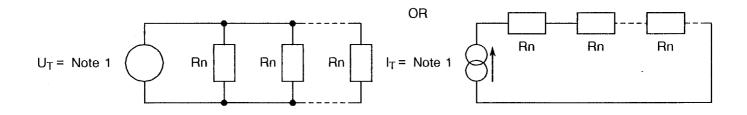
TABLE 5 - CONDITIONS FOR BURN-IN AND OPERATING LIFE TESTS

NO.	CHARACTERISTIC	SYMBOL	CONDITION	UNIT
1	Ambient Temperature for Initial Measurement	T _{amb}	+ 22 ± 3	°C
2	Temperature for Burn-in and Operating Life	T _{amb}	+ 25 ± 3	°C
3	Voltage or Current applied	U _T or I _T	Note 1 to Figure 5	-
4* ***	Temperature for Final Measurement	T _{amb}	+ 22 ± 3	°C

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN AND OPERATING LIFE TESTS

FIGURE 5(a) - PARALLEL CIRCUIT

FIGURE 5(b) - SERIES CIRCUIT



<u>NOTES</u>

1.

$$U_T = 120V$$
 or \sqrt{PnRn} .

$$I_T = \frac{120V}{Rn}$$
 or $\sqrt{\frac{Pn}{Rn}}$

whichever is smaller, with the P_n value according to Tolerance (see Table 1(a)).



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4.8 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESA/SCC GENERIC SPECIFICATION NO. 4002)</u>

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. The measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6. The measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance tests are scheduled in Table 6. The measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.8.4 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life testing are specified in Section 9 of ESA/SCC Generic Specification No. 4002. The conditions for operating life testing shall be as specified in Table 5 and Para. 4.7.2 of this specification.

4.8.5 Electrical Circuits for Operating Life Tests

The circuit for use in performing the operating life tests is shown in Figure 5.

4.8.6 Conditions for High Temperature Storage Test (Part of Endurance Testing)

The requirements for the high temperature storage test are specified in Section 9 of ESA/SCC Generic Specification No. 4002. The conditions for high temperature storage shall be $T_{amb} = +275(+0.5)$ °C.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

	ESA/SCC GENERIC	SPEC. No. 4002	MEASUREMENTS AN		LIM	ITS		
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
01	Overload	Para. 9.1 and Para. 4.2.2 of this specification	Initial Measurements Resistance Final Measurements Visual Examination	Table 2 Item 1 After 1 to 2 hrs recovery No damage	R _A	Table 2	Item 1	•
			Resistance Change	Legible marking Table 2 Item 1	ΔR _A /R _A	± (0.25 + <u>0</u>) <u>.05</u> ×100) R _n	%
02	Permanence of Marking	Para. 9.6	Final Measurements Visual Examination	No corrosion or obliteration of marking	-	-	-	-
03	Temperature Characteristic of Resistance	Para. 9.7 Procedure II	During Test Temperature Characteristic of Resistance	Para. 9.7.3 of ESA/SCC No. 4002	TCR	Table	e 1(a)	10 ^{−6} /°C
04	Voltage Proof (Altitude)	Para. 9.8	During Test Visual Examination	100Vrms for 5 seconds No Breakdown or Flashover	-	-	-	-
05	Solderability	Para. 9.9 Procedure II	Final Measurements Visual Examination	No damage Legible marking		-	•	-
06	Robustness of Terminations	Para 9.10 and Para. 4.3.3 of this specification	Initial Measurements Resistance Final Measurements Visual Examination Resistance Change	Table 2 Item 1 No damage Table 2 Item 1	R _A - ΔR _A /R _A	Table 2 - ± (0.25 + <u>(</u>	ttem 1 - 0.05×100) R _n	- %
07	Resistance to Soldering Heat	Para. 9.11 Procedure I	Initial Measurements Resistance Final Measurements	Table 2 Item 1 After 24 ± 4 hours recovery	R _A	Table 2		
			Visual Examination Resistance Change	No damage Legible marking Table 2 Item 1	- ΔR _A /R _A	- ±(0.1+ <u>0</u>	- .01×100) R _n	- %
80	Rapid Change of Temperature	Para. 9.12 and Table 1(b) of this spec.	Initial Measurements Resistance Final Measurements	Table 2 Item 1 After 1 to 2 hrs recovery	R _A	Table 2	Item 1	
			Visual Examination Resistance Change	No damage Table 2 Item 1	- ΔR _A /R _A	- ± (0.5 + <u>0</u>	. <u>05</u> ×100) R _n	- %
09	Vibration	Para. 9.13	Initial Measurements Resistance Final Measurements Visual Examination Resistance Change	Table 2 Item 1 No damage Table 2 Item 1	R _A - ΔR _A /R _A	Table 2	ttem 1 - 0.05×100)	- %
				1000 2 10111	A/11A	_ (0.20 . 0	R _n	,6

NOTES

1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)

	ESA/SCC GENERIC	SPEC. NO. 4002	MEASUREMENTS AN	ID INSPECTIONS		LIMITS		
NO.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
10	Climatic Sequence	Para. 9.14 Procedure I	Initial Measurements Resistance Final Measurements Visual Examination	After Drying Table 2 Item 1 After 1 to 2 hrs recovery	R _A	Table 2	Item 1	
			Resistance Change	No damage Legible marking Table 2 Item 1	$\Delta R_A/R_A$	± (1.0 + <u>0.</u>	<u>05</u> ×100) R _n	%
			Insulation Resistance	Table 2 Item 2	R_i	1000		$M\Omega$
11	Operating Life	Para. 9.15 Chart IV	Initial Measurements Resistance Intermediate Measurements	Table 2 Item 1 1000 ± 48 hrs After 1 to 2 hrs	R _A	Table 2	Item 1	
			Resistance Change Final Measurements	recovery Table 2 Item 1 2000 ± 48 hrs After 1 to 2 hrs recovery	$\Delta R_A/R_A$	± (0.35 + <u>0</u>	1 <u>0.05</u> ×100) R _n	%
			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	± (0.5 + <u>0</u> .		%
			Visual Examination	No damage	-	-	R _n	-
	e san	Para. 9.15 Chart V	Initial Measurements Resistance Final Measurements	Table 2 Item 1 1000 ± 48 hrs After 1 to 2 hrs	R _A	Table 2	Item 1	
			Resistance Change	recovery Table 2 Item 1	$\Delta R_A/R_A$	± (0.35 + 0	. <u>05</u> ×100) R _n	%
			Visual Examination	No damage	-	-		_
12	High Temperature Storage	Para. 9.16	Initial Measurements Resistance Intermediate Measurements	Table 2 Item 1 1000 ±48 hrs	R _A	Table 2	Item 1	
			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	± (0.35 + 0		%
			Final Measurements Resistance Change	2000 ± 48 hrs Table 2 Item 1	$\Delta R_A/R_A$	± (0.5 + <u>0.</u>	R _n <u>05</u> ×100) R _n	%
13	External Visual Inspection	Para. 9.17	Visual Inspection	ESA/SCC No. 20500	-	-	-	-
14	Maximum Time Constant (Not applicable to inductive resistors)	Para. 9.18 and Paras 4.2.4 and 4.2.5 of this spec.	Not applicable					

NOTES: See Page 17.